

Notice of References Cited	Application/Control No. 10/540,936		Applicant(s)/Patent Under Reexamination KUHN ET AL.	
	Examiner David M. Naff		Art Unit 1657	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0115742	08-2002	Trieu et al.	523/113
*	B	US-6,696,258	02-2004	Wei et al.	435/7.2
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	19929616	04-2001	De	Bottcher et al	-----
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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	X				

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